Sub-Nanoseconds Time Measurement Systems: USB2.0-TDC Series

Device	No. of GPX Chips	Input Chanels	Operation Mode (TDC Chip)	Readout Rate (Intern)	Data Format*	Transfer Rate (USB 2.0)	PC Readout
Dual Channel USB2.0-TDC 	1	2 Stop (diff. PECL) 1 Start (LVTTL) 2x BNC Terminals for measurement control Input/ Output (TTL)	- R Mode/ 27 ps time bin - G Mode/ 40 ps time bin	40 MHz	- Raw Data - FPGA pre-calculated Data (custom specific programming)	> 25 MByte/ s guaranteed (max. 30 MByte/ s)	Windows DLL LabVIEW VI Interface
Quad Channel USB2.0-TDC 	2	4 Stop (diff. PECL) 1 Start (LVTTL) 2x BNC Terminals for measurement control Input/ Output (TTL)	- R Mode/ 27 ps time bin - G Mode/ 40 ps time bin	80 MHz	- Raw Data - FPGA pre-calculated Data (custom specific programming)	> 25 MByte/ s guaranteed (max. 30 MByte/ s)	Windows DLL LabVIEW VI Interface
USB2.0-TDC 	1	8 Stop (LVTTL) 1 Start (LVTTL) 2x BNC Terminals for measurement control Input/ Output (TTL)	I Mode/ 82 ps time bin	40 MHz	- Raw Data - FPGA pre-calculated Data (custom specific programming)	> 25 MByte/ s guaranteed (max. 30 MByte/ s)	Windows DLL LabVIEW VI Interface
Double USB2.0-TDC 	2	16 Stop (LVTTL) 2 Start (LVTTL) 2x BNC Terminals for measurement control Input/ Output (TTL)	I Mode/ 82 ps time bin	80 MHz	- Raw Data - FPGA pre-calculated Data (custom specific programming)	> 25 MByte/ s guaranteed (max. 30 MByte/ s)	Windows DLL LabVIEW VI Interface

*Surface Concept offers a custom specific FPGA programming for the pre-calculation of data to increase the effective transfer rate.